

Notice of References Cited	Application/Control No. 10/706,498		Applicant(s)/Patent Under Reexamination ALLEN ET AL.	
	Examiner Anthony Weier		Art Unit 1761	Page 1 of 1

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*	D	US-3,930,037	12-1975	Yokoyama et al.	426/268
*	E	US-6,376,722	04-2002	Sanz et al.	568/816
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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